

Search Notes

Application/Control No.

10/754,060

Examiner

Thinh T. Nguyen

Applicant(s)/Patent under
Reexamination

LIAO ET AL.

Art Unit

2818

SEARCHED

Class	Subclass	Date	Examiner
257	52	3/31/2005	TTN
257	61	3/31/2005	TTN
257	55	3/31/2005	TTN
257	56	3/31/2005	TTN
257	62	4/1/2005	TTN
257	63	4/1/2005	TTN
257	67	4/1/2005	TTN

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST	3/31/2005	TTN
EAST	4/1/2005	TTN